Quad MECL to TTL Translator

The MC10125 is a quad translator for interfacing data and control signals between the MECL section and saturated logic sections of digital systems. The MC10125 incorporates differential inputs and Schottky TTL "totem pole" outputs. Differential inputs allow for use as an inverting/ non–inverting translator or as a differential line receiver. The VBB reference voltage is available on pin 1 for use in single–ended input biasing. The outputs of the MC10125 go to a low logic level whenever the inputs are left floating.

Power supply requirements are ground, +5.0 Volts and -5.2 Volts. Propagation delay of the MC10125 is typically 4.5 ns. The MC10125 has fanout of 10 TTL loads. The dc levels are MECL 10,000 in and Schottky TTL, or TTL out. This device has an input common mode noise rejection of \pm 1.0 Volt.

An advantage of this device is that MECL level information can be received, via balanced twisted pair lines, in the TTL equipment. This isolates the MECL logic from the noisy TTL environment. This device is useful in computers, instrumentation, peripheral controllers, test equipment and digital communications systems.

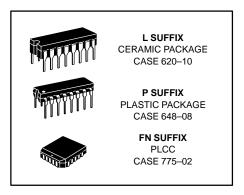
 $P_D = 380 \text{ mW typ/pkg (No Load)}$ $t_{pd} = 4.5 \text{ ns typ } (50\% \text{ to + 1.5 Vdc out)}$ t_r , $t_f = 2.5 \text{ ns typ } (1.0 \text{ V to } 2.0 \text{ V})$

LOGIC DIAGRAM 2 3 4 6 7 5 10 11 12 14 15 Gnd = PIN 16 VCC (+5.0Vdc) = PIN 9 VEE (-5.2Vdc) = PIN 8

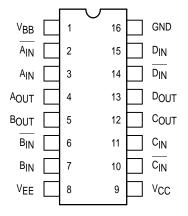
 $^*V_{BB}$ to be used to supply bias to the MC10125 only and bypassed (when used) with 0.01 μF to 0.1 μF capacitor to ground (0 V). V_{BB} can source < 1.0 mA.

When the input pin with the bubble goes positive, the output goes negative.

MC10125



DIP PIN ASSIGNMENT



Pin assignment is for Dual-in-Line Package.
For PLCC pin assignment, see the Pin Conversion
Tables on page 6–11 of the Motorola MECL Data
Book (DL122/D).



ELECTRICAL CHARACTERISTICS

			Test Limits							
		Pin Under	-30)°C		+25°C		+85	5°C	1
Characteristic	Symbol	Test	Min	Max	Min	Тур	Max	Min	Max	Unit
Negative Power Supply Drain Current	ΙE	8		-44			-40		-44	mAdc
Positive Power Supply Drain	Іссн	9		52			52		52	mAdc
Current	ICCL	9		39			39		39	mAdc
Input Current	I _{inH} 1	2		180			115		115	μAdc
Input Leakage Current	ІСВО	2		1.5			1.0		1.0	μAdc
High Output Voltage	Vон	4	2.5		2.5			2.5		Vdc
Low Output Voltage	V _{OL}	4		0.5			0.5		0.5	Vdc
High Threshold Voltage	VOHA	4	2.5		2.5			2.5		Vdc
Low Threshold Voltage	VOLA	4		0.5			0.5		0.5	Vdc
Indeterminate Input	V _{OLS1}	4		0.5			0.5		0.5	Vdc
Protection Tests	V _{OLS2}	4		0.5			0.5		0.5	Vdc
Short Circuit Current	los	4	40	100	40		100	40	100	mAdc
Reference Voltage	V _{BB}	1	-1.420	-1.280	-1.350		-1.230	-1.295	-1.150	Vdc
Common Mode Rejection Tests	Voн	4 4	2.5 2.5		2.5 2.5			2.5 2.5		Vdc
	V _{OL}	4 4		0.5 0.5			0.5 0.5		0.5 0.5	Vdc
Switching Times (50Ω Load)										ns
Propagation Delay (50% to +1.5Vdc)	t ₆₊₅ - t ₆₋₅₊ t ₂₊₄₋ t ₂₋₄₊	5 5 4 4	1.0 1.0 1.0 1.0	6.0 6.0 6.0 6.0	1.0 1.0 1.0 1.0	4.5 4.5 4.5 4.5	6.0 6.0 6.0 6.0	1.0 1.0 1.0 1.0	6.0 6.0 6.0 6.0	
Rise Time (+1.0V to 2.0V)	t ₄₊	4		3.3			3.3		3.3	
Fall Time (+1.0V to 2.0V)	t ₄ _	4		3.3			3.3		3.3	

Individually test each output, apply V_{IHmax} to pin under test.

MOTOROLA 3–90

ELECTRICAL CHARACTERISTICS (continued)

			TEST VOLTAGE VALUES (Volts)							
@ Test Temperature −30°C			V _{IHmax}	V _{ILmin}	VIHAmin	V _{ILAmax}	V _{IHH}	V _{ILH}		
			-0.890	-1.890	-1.205	-1.500	+0.110	-0.890		
		+25°C	-0.810	-1.850	-1.105	-1.475	+0.190	-0.850		
		+85°C	-0.700	-1.825	-1.035	-1.440	+0.300	-0.825		
		Pin Under	TEST VOLTAGE APPLIED TO PINS LISTED BELOW							0
Characteristic	Symbol	Test	V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{IHH}	V _{ILH}	Gnd	Output Condition
Negative Power Supply Drain Current	lΕ	8							16	
Positive Power Supply	ICCH	9	2,6,10,14						16	
Drain Current	ICCL	9		2,6,10,14					16	
Input Current	_{linH} 1	2	2,6,10,14						16	
Input Leakage Current	I _{CBO}	2							16	
High Output Voltage	Voн	4		2,6,10,14					16	-2.0mA
Low Output Voltage	VOL	4	2,6,10,14						16	20mA
High Threshold Voltage	VOHA	4		6,10,14		2			16	–2.0mA
Low Threshold Voltage	V_{OLA}	4	6,10,14		2				16	20mA
Indeterminate Input	V _{OLS1}	4							16	20mA
Protection Tests	V _{OLS2}	4							16	20mA
Short Circuit Current	los	4		2,6,10,14					4, 16	
Reference Voltage	V_{BB}	1		2,6,10,14						
Common Mode Rejection Tests	Vон	4 4					3	2	16 16	–2.0mA –2.0mA
	V _{OL}	4 4					2	3	16 16	20mA 20mA
Switching Times (50 Ω Load)			Pulse In	Pulse Out	C _L (pF)					
Propagation Delay (50% to +1.5Vdc)	[†] 6+5– [†] 6–5+ [†] 2+4– [†] 2–4+	5 5 4 4	6 6 2 2	5 5 4 4	25 25 25 25 25				16 16 16 16	
Rise Time (+1.0V to 2.0V)	t ₄₊	4	2	4	25				16	
Fall Time (+1.0V to 2.0V)	t ₄ _	4	2	4	25				16	

Individually test each output, apply V_{IHmax} to pin under test.

3–91 MOTOROLA

ELECTRICAL CHARACTERISTICS (continued)

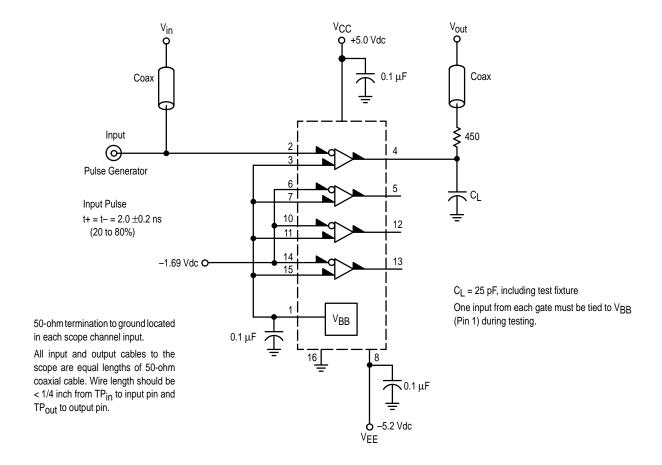
			TEST VOLTAGE VALUES (Volts)						
(0)	VIHH	VILH	V _{BB}	Vcc	VEE				
		-30°C	-1.890	-2.890	From	+5.0	-5.2		
		+25°C	-1.810	-2.850	Pin	+5.0	-5.2		
+85°C				-2.825	1	+5.0	-5.2		
		Pin Under	TEST VOLTAGE APPLIED TO PINS LISTED BELOW						•
Characteristic	Symbol	Test	VIHH	VILH	V _{BB}	VCC	VEE	Gnd	Output Condition
Negative Power Supply Drain Current	ΙE	8			3,7,11,15	9	8	16	
Positive Power Supply	Іссн	9			3,7,11,15	9	8	16	
Drain Current	ICCL	9			3,7,11,15	9	8	16	
Input Current	I _{inH} 1	2			3,7,11,15	9	8	16	
Input Leakage Current	Ісво	2			3,7,11,15	9	2,6,8,10,14	16	
High Output Voltage	Voн	4			3,7,11,15	9	8	16	-2.0mA
Low Output Voltage	VOL	4			3,7,11,15	9	8	16	20mA
High Threshold Voltage	VOHA	4			3,7,11,15	9	8	16	-2.0mA
Low Threshold Voltage	VOLA	4			3,7,11,15	9	8	16	20mA
Indeterminate Input Protection Tests	V _{OLS1}	4				9	2,3,6,7,8, 10,11,14,15	16	20mA
	V _{OLS2}	4				9	8	16	20mA
Short Circuit Current	los	4			3,7,11,15	9	8	4, 16	
Reference Voltage	V _{BB}	1			3,7,11,15				
Common Mode Rejection Tests	Voн	4 4	3	2		9 9	8 8	16 16	–2.0mA –2.0mA
	VOL	4 4	2	3		9 9	8 8	16 16	20mA 20mA
Switching Times (50Ω Load)									
Propagation Delay (50% to +1.5Vdc)	t6+5- t6-5+ t2+4- t2-4+	5 5 4 4			3,7,11,15 3,7,11,15 3,7,11,15 3,7,11,15	9 9 9	8 8 8 8	16 16 16 16	
Rise Time (+1.0V to 2.0V)	t ₄₊	4			3,7,11,15	9	8	16	
Fall Time (+1.0V to 2.0V)	t ₄₋	4			3,7,11,15	9	8	16	

Individually test each output, apply V_{IHmax} to pin under test.

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to –2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

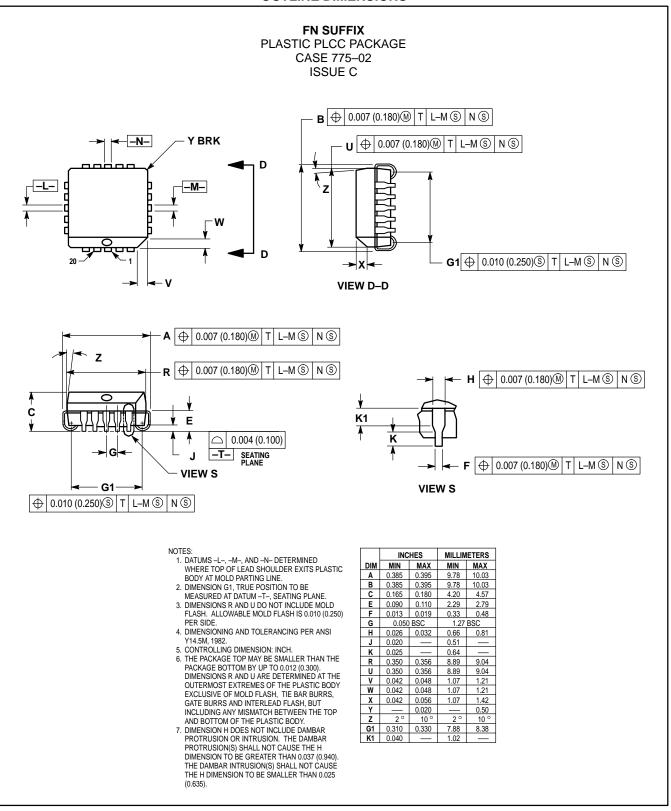
MOTOROLA 3–92

SWITCHING TIME TEST CIRCUIT



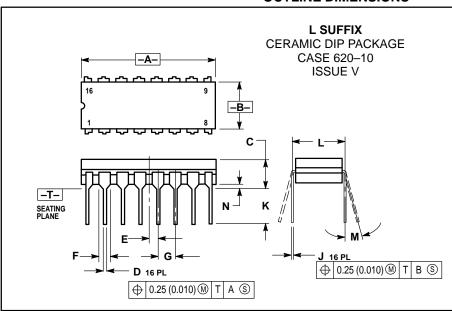
3–93 MOTOROLA

OUTLINE DIMENSIONS



MOTOROLA 3–94

OUTLINE DIMENSIONS

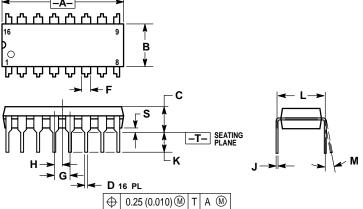


NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
- DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC

	INC	HES	MILLIMETERS				
DIM	MIN	MAX	MIN	MAX			
Α	0.750	0.785	19.05	19.93			
В	0.240	0.295	6.10	7.49			
С		0.200		5.08			
D	0.015	0.020	0.39	0.50			
Е	0.050	BSC	1.27 BSC				
F	0.055	0.065	1.40	1.65			
G	0.100	BSC	2.54 BSC				
Н	0.008	0.015	0.21	0.38			
K	0.125	0.170	3.18	4.31			
L	0.300	BSC	7.62 BSC				
M	0°	15°	0 °	15°			
N	0.020	0.040	0.51	1.01			





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL
- DIMENSION B DOES NOT INCLUDE MOLD FLASH.
- ROUNDED CORNERS OPTIONAL

	INC	HES	MILLIMETERS				
DIM	MIN	MAX	MIN	MAX			
Α	0.740	0.770	18.80	19.55			
В	0.250	0.270	6.35	6.85			
С	0.145	0.175	3.69	4.44			
D	0.015	0.021	0.39	0.53			
F	0.040	0.70	1.02	1.77			
G	0.100	BSC	2.54 BSC				
Н	0.050	BSC	1.27 BSC				
J	0.008	0.015	0.21	0.38			
K	0.110	0.130	2.80	3.30			
L	0.295	0.305	7.50	7.74			
М	0°	10 °	0°	10 °			
S	0.020	0.020 0.040		1.01			

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical parameters, including or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and (A) are registered trademarks of Motorola, Inc. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

How to reach us:

USA/EUROPE/Locations Not Listed: Motorola Literature Distribution; P.O. Box 20912; Phoenix, Arizona 85036. 1-800-441-2447 or 602-303-5454

MFAX: RMFAX0@email.sps.mot.com - TOUCHTONE 602-244-6609 INTERNET: http://Design-NET.com

JAPAN: Nippon Motorola Ltd.; Tatsumi-SPD-JLDC, 6F Seibu-Butsuryu-Center, 3-14-2 Tatsumi Koto-Ku, Tokyo 135, Japan. 03-81-3521-8315

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852-26629298



MC10125/D

Find price and stock options from leading distributors for MC10125P on Findchips.com:

https://findchips.com/search/MC10125P

Find CAD models and details for this part:

https://findchips.com/detail/mc10125p/Freescale-Semiconductor